


<b>Search Notes</b>  	<b>Application/Control No.</b>  10567121	<b>Applicant(s)/Patent Under Reexamination</b>  HATANO ET AL.
	<b>Examiner</b>  NAISHADH N DESAI	<b>Art Unit</b>  2834

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
Searched 310/91 with keywords	10/27/2008	NND
IDS and INV search	10/27/2008	NND
Global search with keywords	10/27/2008	NND

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

/NAISHADH N DESAI/  
Examiner.Art Unit 2834